

WHAT IS CLAIMED IS:

1. An active matrix type display device, comprising:

a plurality of gate lines;

5 a plurality of data lines crossing said plurality of gate lines;

a plurality of pixel electrodes;

a thin film transistor disposed at each intersection between said plurality of gate lines and said plurality of data lines, and including a gate electrode and an active region, said gate electrode being connected to one of said plurality of gate lines, and said active region having a first region connected to one of said plurality of data lines and a second region connected to a corresponding one of said plurality of pixel electrodes; and

10 a gate line driver for sequentially applying a gate selection signal with a pulse-shaped voltage waveform to a selected one of said plurality of gate lines; wherein

said gate line driver causes a falling edge of said gate selection signal with said pulse-shaped voltage waveform to be smoother than a rising edge thereof.

2. The active matrix type display device according to claim 1, wherein said gate selection signal requires at least a time $t/2$ to fall, where t is the time from when a first gate line assumes an unselected state to when subsequent second gate line assumes a selected state.

3. The active matrix type display device according to claim 1, wherein said gate selection signal falls over a time at least ten times the time required for the signal to rise.

5 4. The active matrix type display device according to claim 1, wherein

said gate line driver includes a gate buffer provided at a final stage and connected to a corresponding one of said plurality of gate lines,

10 said gate buffer includes a transistor having first and second regions of an active layer respectively connected to the ground and to said corresponding gate line, and

the condition, $2.5(R1+R2)*(C1+C2) < t < 5(R1+R2)*(C1+C2)$, is satisfied, wherein

15 R1 represents a total resistance of said gate line and the gate electrodes of the thin film transistors connected to said gate line in a pixel region,

20 C1 represents a total capacitance of capacitors connected to said gate line in the pixel region and having said gate line as one electrode,

R2 represents a channel resistance of the transistor in said gate buffer,

25 C2 represents a capacitance of a capacitor formed by said active layer of the transistor in said gate buffer and the gate electrode of said transistor, and

t represents a flyback period in a horizontal scanning period.

5. The active matrix type display device according to claim 4, wherein a channel length L and a channel width W of the transistor in said gate buffer satisfy the condition $W/L < 1$.

5 6. The active matrix type display device according to claim 1, wherein

said gate line driver includes a gate buffer provided at a final stage and connected to a corresponding one of said plurality of gate lines,

10 said gate buffer includes a transistor having first and second regions of an active layer respectively connected to the ground and to said corresponding gate line, and

a channel length L and a channel width W of the transistor in said gate buffer satisfy the condition $W/L < 1$.

15 7. The active matrix type display device according to claim 1, wherein

20 said gate line driver includes a gate buffer provided at a final stage and connected to a corresponding one of said plurality of gate lines,

said gate buffer includes a current supplying transistor having first and second regions of an active layer connected between a power source and said corresponding gate line, and a current discharging transistor having first and second regions of an active layer respectively connected to the ground and to said corresponding gate line, and

the ratio (channel width W)/(channel length L) of said current

supplying transistor differs from the ratio (channel width W)/(channel length L) of said current discharging transistor.

8. The active matrix type display device according claim 7,
5 wherein

the condition, $2.5(R1+R2)*(C1+C2) < t < 5(R1+R2)*(C1+C2)$, is satisfied, wherein

R1 represents a total resistance of said gate line and the gate electrodes of the thin film transistors connected to said gate
10 line in a pixel region,

C1 represents a total capacitance of capacitors connected to said gate line in the pixel region and having said gate line as one electrode,

R2 represents a channel resistance of the current discharging
15 transistor in said gate buffer,

C2 represents a capacitance of a capacitor formed by said active layer of the current discharging transistor in said gate buffer and the gate electrode thereof, and

t represents a flyback period in a horizontal scanning period.

20 9. The active matrix type display device according to claim 8, wherein the channel length L and the channel width W of the current discharging transistor in said gate buffer satisfy the condition $W/L < 1$.

25 10. The active matrix type display device according to claim 8, wherein the condition that the ratio of (the ratio W/L of said

current supplying transistor) / (the ratio W/L of said current discharging transistor) is greater than 1 is satisfied.

11. The active matrix type display device according to claim 5 8, wherein the condition that the ratio of (the ratio W/L of said current supplying transistor) / (the ratio W/L of said current discharging transistor) is greater than 5 is satisfied.

12. An active matrix type display device, comprising:
10 a plurality of gate lines;
a plurality of data lines crossing said plurality of gate lines;

a plurality of pixel electrodes;
a thin film transistor disposed at each intersection between
15 said plurality of gate lines and said plurality of data lines, and including a gate electrode and an active region, said gate electrode being connected to one of said plurality of gate lines, and said active region having a first region connected to one of said plurality of data lines and a second region connected to a
20 corresponding one of said plurality of pixel electrodes; and

a gate line driver for sequentially applying a gate selection signal with a pulse-shaped voltage waveform to a selected one of said plurality of gate lines; wherein

said gate line driver causes a falling time of said gate
25 selection signal to be longer than a rising time thereof.

13. The active matrix type display device according to claim

12, wherein said gate selection signal requires at least a time $t/2$ to fall, where t is a time from when a first gate line assumes an unselected state to when a subsequent second gate line assumes a selected state.

5

14. The active matrix type display device according to claim 12, wherein said gate selection signal falls over a time at least ten times the time required for the signal to rise.

10 15. The active matrix type display device according to claim 12, wherein

said gate line driver includes a gate buffer provided at a final stage and connected to a corresponding one of said plurality of gate lines,

15 said gate buffer includes a transistor having first and second regions of an active layer respectively connected to the ground and to said corresponding gate line, and

the condition, $2.5(R1+R2)*(C1+C2) < t < 5(R1+R2)*(C1+C2)$, is satisfied, wherein

20 $R1$ represents a total resistance of said gate line and the gate electrodes of the thin film transistors connected to said gate line in a pixel region,

$C1$ represents a total capacitance of capacitors connected to said gate line in the pixel region and having said gate line as
25 one electrode,

$R2$ represents a channel resistance of the transistor in said gate buffer,

C2 represents a capacitance of a capacitor formed by said active layer of the transistor in said gate buffer and the gate electrode of said transistor, and

t represents a flyback period in a horizontal scanning period.

5

16. The active matrix type display device according to claim 15, wherein a channel length L and a channel width W of the transistor in said gate buffer satisfy the condition $W/L < 1$.

10

17. The active matrix type display device according to claim 12, wherein

said gate line driver includes a gate buffer provided at a final stage and connected to a corresponding one of said plurality of gate lines,

15

said gate buffer includes a transistor having first and second regions of an active layer respectively connected to the ground and to said corresponding gate line, and

a channel length L and a channel width W of the transistor in said gate buffer satisfy the condition $W/L < 1$.

20

18. The active matrix type display device according to claim 12, wherein

said gate line driver includes a gate buffer provided at a final stage and connected to a corresponding one of said plurality of gate lines,

25

said gate buffer includes a current supplying transistor having first and second regions of an active layer connected

between a power source and said corresponding gate line, and a current discharging transistor having first and second regions of an active layer respectively connected to the ground and to said corresponding gate line, and

5 the ratio (channel width W)/(channel length L) of said current supplying transistor differs from the ratio (channel width W)/(channel length L) of said current discharging transistor.

19. The active matrix type display device according claim
10 18, wherein

the condition, $2.5(R1+R2)*(C1+C2) < t < 5(R1+R2)*(C1+C2)$, is satisfied, wherein

$R1$ represents a total resistance of said gate line and the gate electrodes of the thin film transistors connected to said gate
15 line in a pixel region,

$C1$ represents a total capacitance of capacitors connected to said gate line in the pixel region and having said gate line as one electrode,

$R2$ represents a channel resistance of the current discharging
20 transistor in said gate buffer,

$C2$ represents a capacitance of a capacitor formed by said active layer of the current discharging transistor in said gate buffer and the gate electrode thereof, and

t represents a flyback period in a horizontal scanning period.
25

20. The active matrix type display device according to claim 18, wherein the channel length L and the channel width W of the

current discharging transistor in said gate buffer satisfy the condition $W/L < 1$.

21. The active matrix type display device according to claim
5 18, wherein the condition that the ratio of (the ratio W/L of said current supplying transistor) / (the ratio W/L of said current discharging transistor) is greater than 1 is satisfied.

22. The active matrix type display device according to claim
10 18, wherein the condition that the ratio of (the ratio W/L of said current supplying transistor) / (the ratio W/L of said current discharging transistor) is greater than 5 is satisfied.